

Search Notes**Application/Control No.**

10/088,694

Examiner

Jacob Meek

Applicant(s)/Patent under Reexamination

HAYATA, TOSHIHIRO

Art Unit

2637

SEARCHED

Class	Subclass	Date	Examiner
375	251,143 150, 152 349,142 354,1	11/28/2005	JM
370	342,350	11/28/2005	JM
455	501,63.1	11/28/2005	JM
455	65,67.13	11/28/2005	JM
455	561,500	11/28/2005	JM
370	310,331	11/28/2005	JM
370	491,332	11/28/2005	JM
455	13.4,38.3	12/6/2005	JM
455	67.3	12/6/2005	JM
455	226.3	12/6/2005	JM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: see search notes	11/28/2005	JM
NPL	11/28/2005	JM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	147	2/24/2006	JM
375	349	2/24/2006	JM